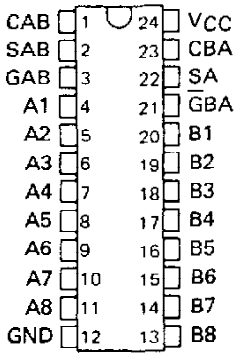
SN54LS651 THRU SN54LS653
SN74LS651 THRU SN74LS653
OCTAL BUS TRANSCEIVERS AND REGISTERS

D2637, JANUARY 1981 – REVISED MARCH 1988

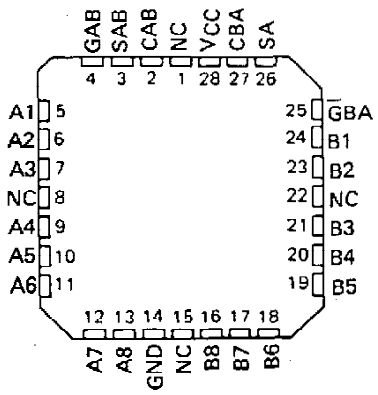
- **Bus Transceivers/Registers**
- **Independent Registers and Enables for A and B Buses**
- **Multiplexed Real-Time and Stored Data**
- **Choice of True and Inverting Data Paths**
- **Choice of 3-State or Open-Collector Outputs to A Bus**
- **Dependable Texas Instruments Quality and Reliability**

DEVICE	A OUTPUT	B OUTPUT	LOGIC
'LS651	3-State	3-State	Inverting
'LS652	3-State	3-State	True
'LS653	Open-collector	3-State	Inverting

SN54LS'. . . JT PACKAGE
SN74LS'. . . DW OR NT PACKAGE
(TOP VIEW)



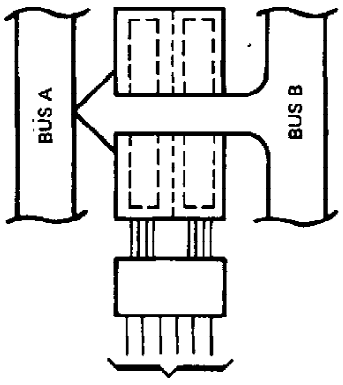
SN54LS'. . . FK PACKAGE
(TOP VIEW)



NC — No internal connection

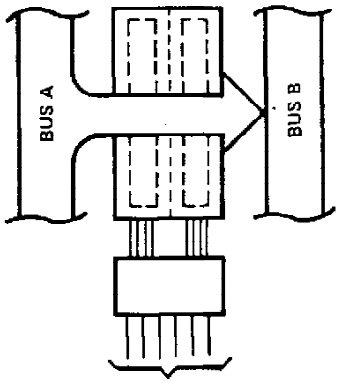
description

These devices consist of bus transceiver circuits, D-type flip-flops, and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. Enable GAB and $\overline{G}$BA are provided to control the transceiver functions. SAB and SBA control pins are provided to select whether realtime or stored data is transferred. A low input level selects real-time data, and a high selects stored data. The following examples demonstrate the four fundamental bus-management functions that can be performed with the 'LS651, 'LS652, and 'LS653.



GAB	$\overline{G}$BA	CAB	CBA	SAB	SBA
L	L	X	X	X	L

REAL-TIME TRANSFER
BUS B TO BUS A



GAB	$\overline{G}$BA	CAB	CBA	SAB	SBA
H	H	X	X	L	X

REAL-TIME TRANSFER
BUS A TO BUS B

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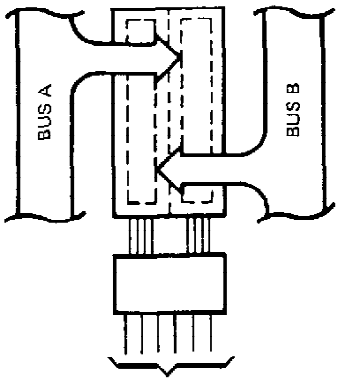
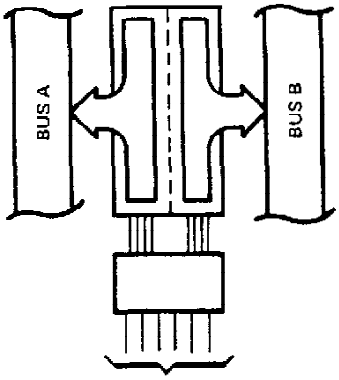


GAB	$\overline{G}$BA	CAB	CBA	SAB	SBA
X	H	↑	X	X	X
L	X	X	↑	X	X
L	H	↑	↑	X	X

STORAGE FROM
A AND/OR B



GAB	$\overline{G}$BA	CAB	CBA	SAB	SBA
H	L	H or L	H or L	H	H

TRANSFER
STORED DATA
TO A AND/OR B

Data on the A or B data bus, or both, can be stored in the internal D flip-flop by low-to-high transitions at the appropriate clock pins (CAB or CBA) regardless of the select or enable control pins. When SAB or SBA are in the real-time transfer mode, it is also possible to store data without using the internal D-type flip-flops by simultaneously enabling GAB and $\overline{G}$BA. In this configuration each output reinforces its input. Thus, when all other data sources to the two sets of bus lines are at high impedance, each set of bus lines will remain at its last state.

The SN54LS651 through SN54LS653 are characterized for operation over the full military temperature range of −55°C to 125°C. The SN74LS651 through SN74LS653 are characterized for operation from 0°C to 70°C.

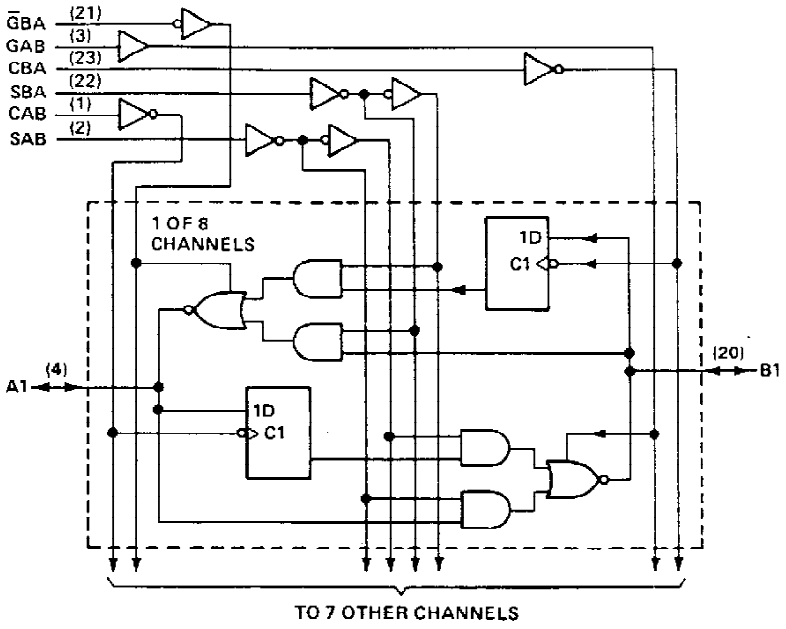
FUNCTION TABLE

INPUTS						DATA I/O*		OPERATION OR FUNCTION	
GAB	$\overline{G}$BA	CAB	CBA	SAB	SBA	A1 THRU A8	B1 THRU B8	'LS651, 'LS653	'LS652, 'LS654
L	H	H or L	H or L	X	X	Input	Input	Isolation	Isolation
L	H	↑	↑	X	X			Store A and B Data	Store A and B Data
X	H	↑	H or L	X	X	Input	Not specified	Store A, Hold B	Store A, Hold B
H	H	↑	↑	X	X	Input	Output	Store A in both registers	Store A in both registers
L	X	H or L	↑	X	X	Not specified	Input	Hold A, Store B	Hold A, Store B
L	L	↑	↑	X	X	Output	Input	Store B in both registers	Store B in both registers
L	L	X	X	X	L	Output	Input	Real-Time $\overline{B}$ Data to A Bus	Real-Time B Data to A Bus
L	L	X	H or L	X	H			Stored $\overline{B}$ Data to A Bus	Stored B Data to A Bus
H	H	X	X	L	X	Input	Output	Real-Time $\overline{A}$ Data to B Bus	Real-Time A Data to B Bus
H	H	H or L	X	H	X			Stored $\overline{A}$ Data to B Bus	Stored A Data to B Bus
H	L	H or L	H or L	H	H	Output	Output	Stored $\overline{A}$ Data to B Bus and Stored $\overline{B}$ Data to A Bus	Stored A Data to B Bus and Stored B Data to A Bus

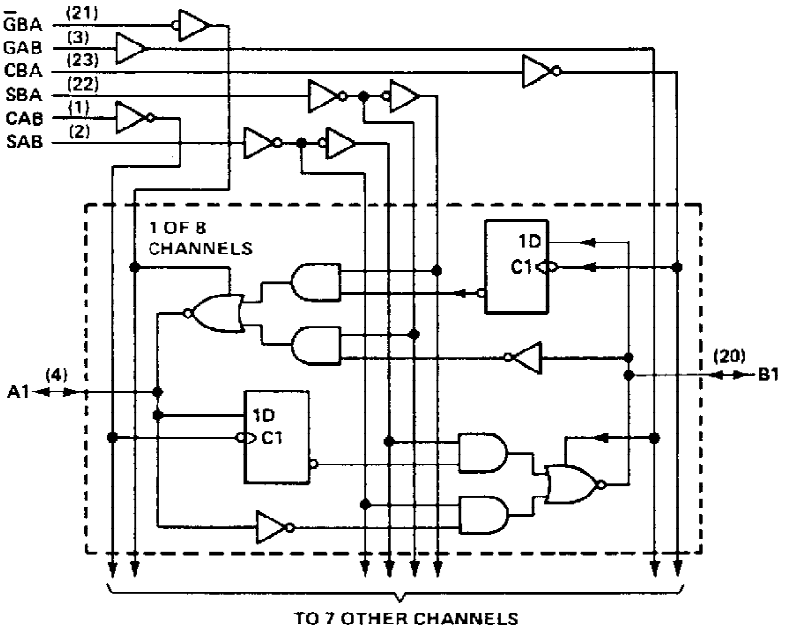
* The data output functions may be enabled or disabled by various signals at the GAB and $\overline{G}$BA inputs. Data input functions are always enabled, i.e., data at the bus pins will be stored on every low-to-high transition on the clock inputs.

logic diagrams (positive logic)

'LS651, 'LS653



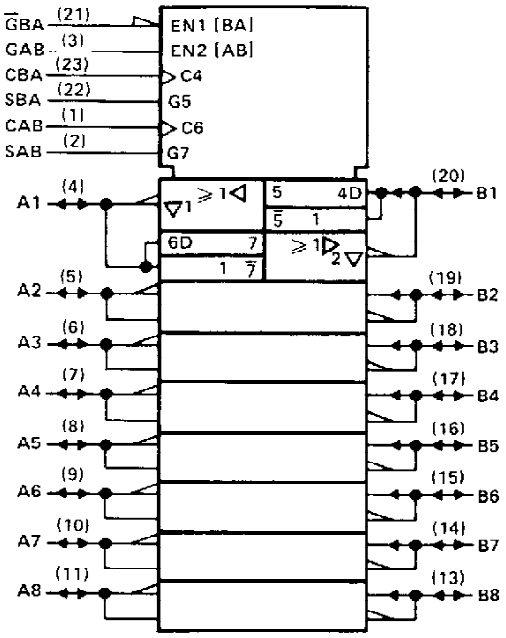
'LS652



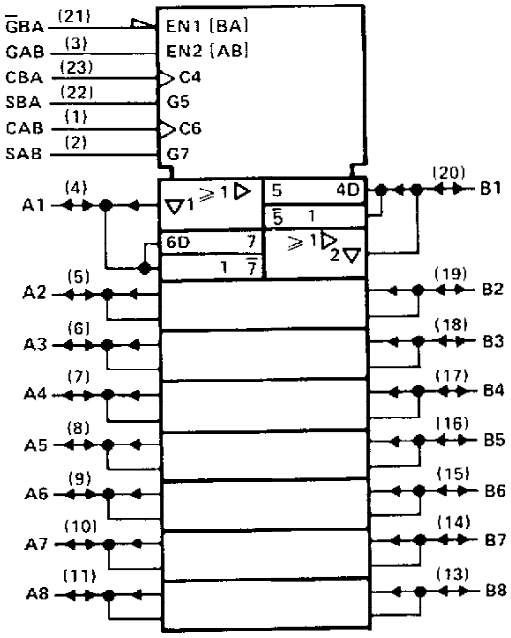
Pin numbers shown are for DW, JT or NT packages.

logic symbols†

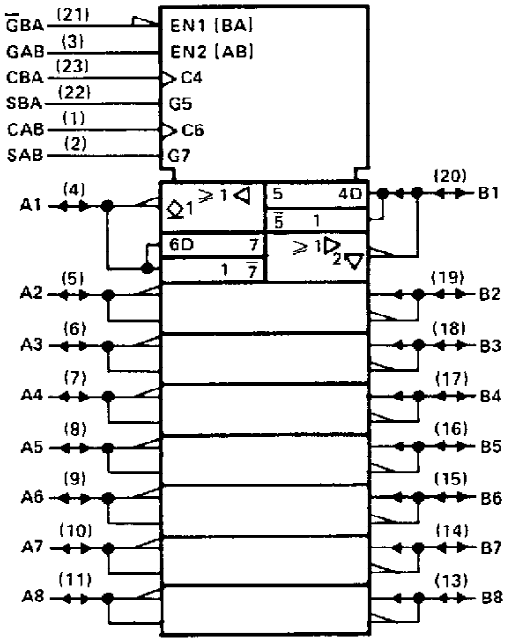
'LS651



'LS652



'LS653



†This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.
Pin numbers shown are for DW, JT, or NT packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage: Control inputs . . . . . 7 V
I/O ports . . . . . 5.5 V
Operating free-air temperature range: SN54LS651, SN54LS652 . . . . . −55°C to 125°C
SN74LS651, SN74LS652 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

			SN54LS651 SN54LS652			SN74LS651 SN74LS652			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
I_{OH}	High-level output current				−12			−15	mA
I_{OL}	Low-level output current				12			24	mA
t_w	Pulse duration	CBA or CAB high	15			15			ns
		CBA or CAB low	15			15			
		Data high or low	15			15			
t_{su}	Setup time before CAB↑ or CBA↑	A or B	15			15			ns
t_h	Hold time after CAB↑ or CBA↑	A or B	0			0			ns
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†			SN54LS651 SN54LS652			SN74LS651 SN74LS652			UNIT
					MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = MIN, I_I = −18 mA					−1.5			−1.5	V
V_{OH}		V_{CC} = MIN, V_{IL} = MAX,	V_{IH} = 2 V,	I_{OH} = −3 mA	2.4	3.4		2.4	3.4		V
				I_{OH} = −12 mA	2						
				I_{OH} = −15 mA				2			
V_{OL}		V_{CC} = MIN, V_{IL} = MAX,	V_{IH} = 2 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
				I_{OL} = 24 mA					0.35	0.5	
I_I	Control inputs	V_{CC} = MAX,	V_I = 7 V				0.1			0.1	mA
	A or B ports	V_{CC} = MAX,	V_I = 5.5 V				0.1			0.1	
I_{IH}	Control inputs	V_{CC} = MAX,	V_I = 2.7 V				20			20	μA
	A or B ports¶						20			20	
I_{IL}	Control inputs	V_{CC} = MAX,	V_I = 0.4 V				−0.4			−0.4	mA
	A or B ports¶						−0.4			−0.4	
I_{OS}§		V_{CC} = MAX,	V_O = 0 V		−40		−225	−40		−225	mA
I_{CC}	LS651	V_{CC} = MAX		Outputs high		95	145		95	145	mA
				Outputs low		103	165		103	165	
				Outputs disabled		103	165		103	165	
	LS652			Outputs high		95	145		95	145	
				Outputs low		103	165		103	165	
				Outputs disabled		120	180		120	180	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.
¶ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

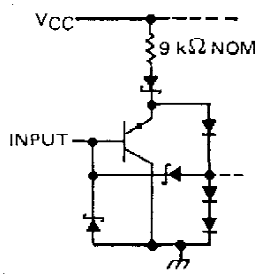
switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS651			'LS652			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
t_{PLH}	Clock	Bus	R_L = 667 Ω, C_L = 45 pF, See Note 2		14	24		15	25	ns
t_{PHL}					23	35		24	36	ns
t_{PLH}	Bus	Bus			9	18		12	18	ns
t_{PHL}					20	30		13	20	ns
t_{PLH}	Select, with bus input high†	Bus			31	47		23	35	ns
t_{PHL}					22	33		21	32	ns
t_{PLH}	Select, with bus input low†				23	35		33	50	ns
t_{PHL}					19	30		15	23	ns
t_{PZH}	$\overline{G}$BA	A Bus			29	44		30	45	ns
t_{PZL}					40	60		36	54	ns
t_{PZH}	GAB	B Bus			19	29		20	30	ns
t_{PZL}					26	40		25	38	ns
t_{PHZ}	$\overline{G}$BA	A Bus	R_L = 667 Ω, C_L = 5 pF, See Note 2		25	38		25	38	ns
t_{PLZ}					19	30		19	30	ns
t_{PHZ}	GAB	B Bus			25	38		25	38	ns
t_{PLZ}					19	30		19	30	ns

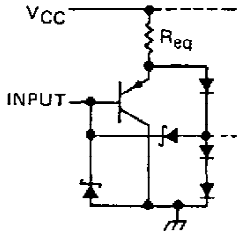
t_{PLH} = propagation delay time, low-to-high-level output.
t_{PHL} = propagation delay time, high-to-low-level output
t_{PZH} = output enable time to high level
t_{PZL} = output enable time to low level
t_{PHZ} = output disable time from high level
t_{PLZ} = output disable time from low level
† These parameters are measured with the internal output state of the storage register opposite to that of the bus input.
NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

schematics of inputs and outputs

EQUIVALENT OF GAB INPUTS

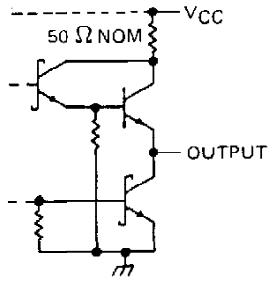


EQUIVALENT OF ALL OTHER INPUTS



A and B: R_{eq} = 15 kΩ NOM
$\overline{G}$BA, CAB and CBA: R_{eq} = 10 kΩ NOM
SAB and SBA: R_{eq} = 6 kΩ NOM

TYPICAL OF ALL OUTPUTS



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} . . . . . 7 V
Input voltage: All inputs and A I/O ports 7V
B I/O ports . . . . . 5.5 V
Operating free-air temperature range: SN54LS653 . . . . . −55°C to 125°C
SN74LS653 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

recommended operating conditions

			SN54LS653			SN74LS653			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
V_{OH}	High-level output voltage	A ports			5.5			5.5	V
I_{OH}	High-level output current	B ports			−12			−15	mA
I_{OL}	Low-level output current				12			24	mA
t_w	Pulse duration	CBA or CAB high	15			15			ns
		CBA or CAB low	30			30			
		Data high or low	30			30			
t_{su}	Setup time before CAB↑ or CBA↑	A or B	15			15			ns
t_h	Hold time after CAB↑ or CBA↑	A or B	0			0			ns
T_A	Operating free-air temperature		−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†			SN54LS653			SN74LS653			UNIT
					MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		V_{CC} = MIN,	I_I = −18 mA				−1.5			−1.5	V
V_{OH}	B ports	V_{CC} = MIN, V_{IL} = MAX	V_{IH} = 2 V,	I_{OH} = −3 mA	2.4	3.4		2.4	3.4		V
				I_{OH} = −12 mA	2						
				I_{OH} = −15 mA				2			
I_{OH}	A ports	V_{CC} = MIN,	V_{OH} = 5.5 V				0.1			0.1	mA
V_{OL}		V_{CC} = MIN, V_{IL} = MAX	V_{IH} = 2 V,	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
				I_{OL} = 24 mA					0.35	0.5	
I_I	Control inputs	V_{CC} = MAX,	V_I = 7 V				0.1			0.1	mA
	A or B ports	V_{CC} = MAX,	V_I = 5.5 V				0.1			0.1	
I_{IH}	Control inputs	V_{CC} = MAX,	V_I = 2.7 V				20			20	μA
	A or B ports¶						20			20	
I_{IL}	Control inputs	V_{CC} = MAX,	V_I = 0.4 V				−0.4			−0.4	mA
	A or B ports¶						−0.4			−0.4	
I_{OS}§	B ports	V_{CC} = MAX,	V_O = 0 V		−40		−225	−40		−225	mA
I_{CC}	LS653	V_{CC} = MAX		Outputs high		95	145		95	145	mA
				Outputs low		103	165		103	165	
				Outputs disabled		103	165		103	165	
	LS654			Outputs high		95	145		95	145	
				Outputs low		105	170		105	170	
				Outputs disabled		120	180		120	180	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.
¶ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

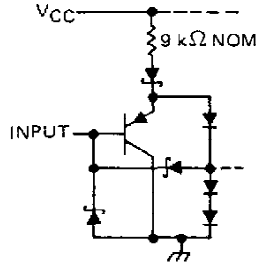
switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	CBA	A Bus	R_L = 667 Ω, C_L = 45 pF, See Note 2		25	38	ns
t_{PHL}					26	39	
t_{PLH}	CAB	B Bus			15	23	ns
t_{PHL}					24	36	
t_{PLH}	A Bus	B Bus			10	18	ns
t_{PHL}					20	30	
t_{PLH}	B Bus	A Bus			21	32	ns
t_{PHL}					16	24	
t_{PLH}	SBA† (with B high)	A Bus			38	57	ns
t_{PHL}					26	39	
t_{PLH}	SBA† (with B low)	A Bus			34	51	ns
t_{PHL}					23	35	
t_{PLH}	SAB† (with A high)	B Bus			32	48	ns
t_{PHL}					22	33	
t_{PLH}	SAB† (with A low)	B Bus			24	36	ns
t_{PHL}					20	30	
t_{PLH}	$\overline{G}$BA	A Bus			23	35	ns
t_{PHL}					37	55	
t_{PZH}	GAB	B Bus	R_L = 667 Ω, C_L = 5 pF, See Note 2		19	29	ns
t_{PZL}					25	38	
t_{PHZ}	GAB	B Bus			26	39	ns
t_{PLZ}					19	29	

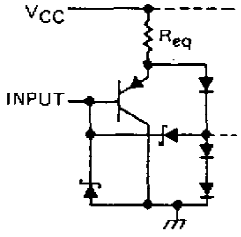
†These parameters are measured with the internal output state of the storage register opposite to that of the bus input.
NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

schematics of inputs and outputs

EQUIVALENT OF GAB INPUTS

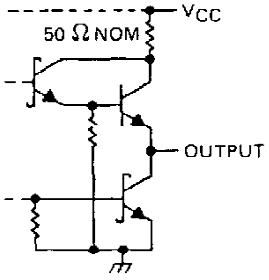


EQUIVALENT OF ALL OTHER INPUTS

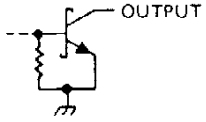


A and B: R_{eq} = 15 kΩ NOM
$\overline{G}$BA, CAB and CBA: R_{eq} = 10 kΩ NOM
SAB and SBA: R_{eq} = 6 kΩ NOM

TYPICAL OF B OUTPUTS



TYPICAL OF A OUTPUTS



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